



Integrated  
Circuit  
Systems, Inc.

**ICS8402**

**350MHz, CRYSTAL-TO-LVCMOS / LVTTL  
FREQUENCY SYNTHESIZER**

PRODUCT DISCONTINUATION NOTICE - LAST TIME BUY EXPIRES NOVEMBER 13, 2015

## GENERAL DESCRIPTION



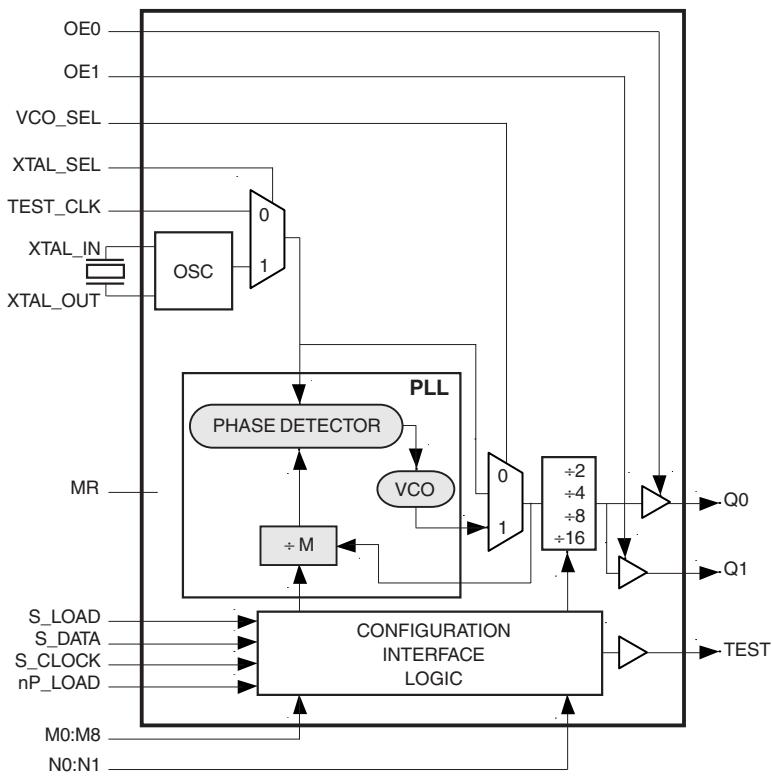
The ICS8402 is a general purpose, Crystal-to-LVCMOS/LVTTL High Frequency Synthesizer and a member of the HiPerClockS™ family of High Performance Clock Solutions from ICS. The ICS8402 has a selectable TEST\_CLK or crystal inputs. The VCO operates at a frequency range of 250MHz to 700MHz. The VCO frequency is programmed in steps equal to the value of the input reference or crystal frequency. The VCO and output frequency can be programmed using the serial or parallel interfaces to the configuration logic. The low phase noise characteristics of the ICS8402 make it an ideal clock source for Gigabit Ethernet and SONET applications.

## FEATURES

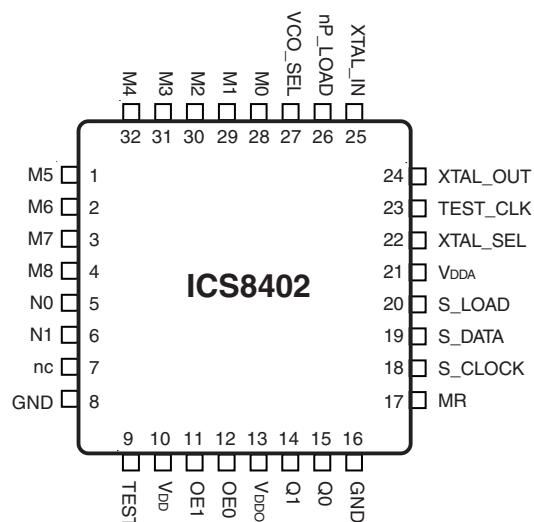
- 2 LVCMOS/LVTTL outputs
- Selectable crystal oscillator interface or LVCMOS/LVTTL TEST\_CLK
- Output frequency range: 15.625MHz to 350MHz
- Crystal input frequency range: 12MHz to 40MHz
- VCO range: 250MHz to 700MHz
- Parallel or serial interface for programming counter and output dividers
- RMS period jitter: 8ps (typical)
- Cycle-to-cycle jitter: 40ps (typical)
- Full 3.3V or mixed 3.3V core/2.5V output supply voltage
- 0°C to 70°C ambient operating temperature

For replacement device use 840N202CKI-dddLF

## BLOCK DIAGRAM



## PIN ASSIGNMENT



32-Lead LQFP  
7mm x 7mm x 1.4mm package body  
**Y Package**  
Top View

32-Lead VFQFN  
5mm x 5mm x 0.75mm package body  
**K Package**  
Top View



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### FUNCTIONAL DESCRIPTION

*NOTE: The functional description that follows describes operation using a 25MHz crystal. Valid PLL loop divider values for different crystal or input frequencies are defined in the Input Frequency Characteristics, Table 5, NOTE 1.*

The ICS8402 features a fully integrated PLL and therefore requires no external components for setting the loop bandwidth. A fundamental crystal is used as the input to the on-chip oscillator. The output of the oscillator is fed into the phase detector. A 25MHz crystal provides a 25MHz phase detector reference frequency. The VCO of the PLL operates over a range of 250MHz to 700MHz. The output of the M divider is also applied to the phase detector.

The phase detector and the M divider force the VCO output frequency to be M times the reference frequency by adjusting the VCO control voltage. Note that for some values of M (either too high or too low), the PLL will not achieve lock. The output of the VCO is scaled by a divider prior to being sent to each of the LVCMOS output buffers. The divider provides a 50% output duty cycle.

The programmable features of the ICS8402 support two input modes to program the M divider and N output divider. The two input operational modes are parallel and serial. *Figure 1* shows the timing diagram for each mode. In parallel mode, the nP\_LOAD input is initially LOW. The data on inputs M0 through M8 and N0 and N1 is passed directly to the M divider and N output divider. On the LOW-to-HIGH transition of the nP\_LOAD input, the data is latched and the M divider remains loaded until the next LOW transition on nP\_LOAD or until a serial event occurs. As a result, the M and N bits can be hardwired to set the M divider and N out-

put divider to a specific default state that will automatically occur during power-up. The TEST output is LOW when operating in the parallel input mode. The relationship between the VCO frequency, the crystal frequency and the M divider is defined as follows:  $f_{VCO} = f_{xtal} \times M$

The M value and the required values of M0 through M8 are shown in Table 3B, Programmable VCO Frequency Function Table. Valid M values for which the PLL will achieve lock for a 25MHz reference are defined as  $10 \leq M \leq 28$ . The frequency out is defined as follows:  $F_{OUT} = \frac{f_{VCO}}{N}$

Serial operation occurs when nP\_LOAD is HIGH and S\_LOAD is LOW. The shift register is loaded by sampling the S\_DATA bits with the rising edge of S\_CLOCK. The contents of the shift register are loaded into the M divider and N output divider when S\_LOAD transitions from LOW-to-HIGH. The M divide and N output divide values are latched on the HIGH-to-LOW transition of S\_LOAD. If S\_LOAD is held HIGH, data at the S\_DATA input is passed directly to the M divider and N output divider on each rising edge of S\_CLOCK. The serial mode can be used to program the M and N bits and test bits T1 and T0. The internal registers T0 and T1 determine the state of the TEST output as follows:

T1	T0	TEST Output
0	0	LOW
0	1	Shift Register Output
1	0	Output of M divider
1	1	CMOS Fout

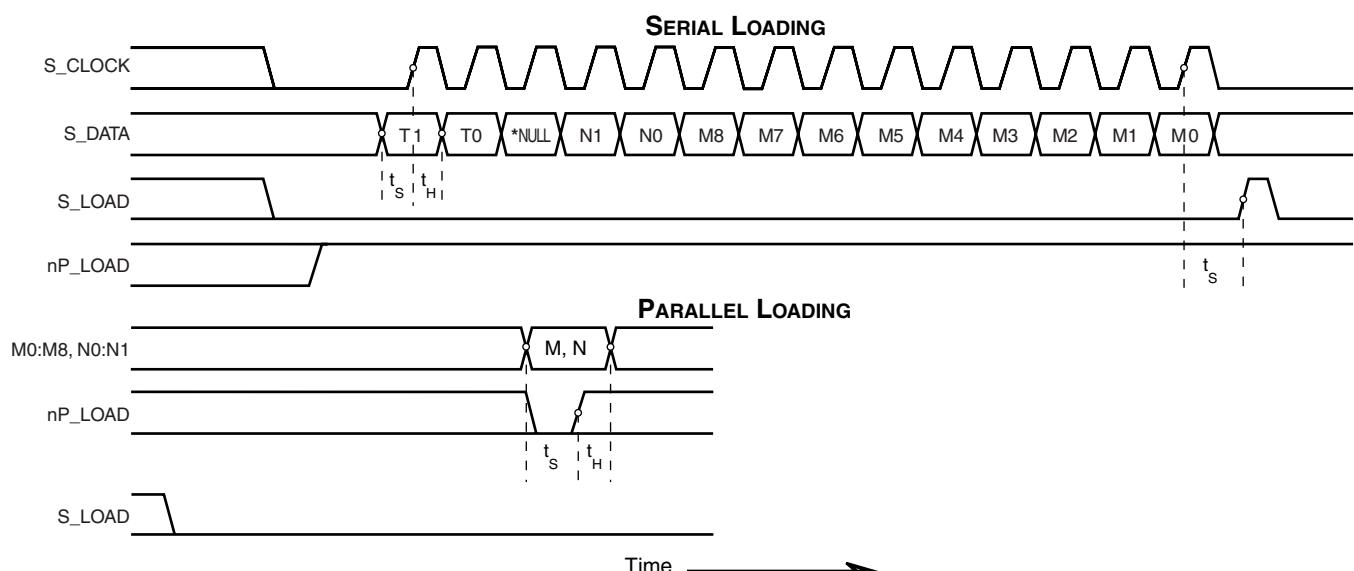


FIGURE 1. PARALLEL & SERIAL LOAD OPERATIONS

\*NOTE: The NULL timing slot must be observed.



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**TABLE 1. PIN DESCRIPTIONS**

Number	Name	Type		Description
1	M5	Input	Pullup	
2, 3, 4, 28, 29, 30, 31, 32	M6, M7, M8, M0, M1, M2, M3, M4	Input	Pulldown	M divider inputs. Data latched on LOW-to-HIGH transition of nP_LOAD input. LVCMOS / LVTTL interface levels.
5, 6	N0, N1	Input	Pulldown	Determines output divider value as defined in Table 3C, Function Table. LVCMOS / LVTTL interface levels.
7	nc	Unused		No connect.
8, 16	GND	Power		Power supply ground.
9	TEST	Output		Test output which is ACTIVE in the serial mode of operation. Output driven LOW in parallel mode. LVCMOS / LVTTL interface levels.
10	V <sub>DD</sub>	Power		Core supply pin.
11, 12	OE1, OE0	Input	Pullup	Output enable. When logic HIGH, the outputs are enabled (default). When logic LOW, the outputs are in Tri-State. See Table 3D, OE Function Table. LVCMOS / LVTTL interface levels.
13	V <sub>DDO</sub>	Power		Output supply pin.
14, 15	Q1, Q0	Output		Clock outputs. LVCMOS / LVTTL interface levels.
17	MR	Input	Pulldown	Active High Master Reset. When logic HIGH, the internal dividers are reset causing the outputs to go low. When logic LOW, the internal dividers and the outputs are enabled. Assertion of MR does not effect loaded M, N, and T values. LVCMOS / LVTTL interface levels.
18	S_CLOCK	Input	Pulldown	Clocks in serial data present at S_DATA input into the shift register on the rising edge of S_CLOCK. LVCMOS / LVTTL interface levels.
19	S_DATA	Input	Pulldown	Shift register serial input. Data sampled on the rising edge of S_CLOCK. LVCMOS / LVTTL interface levels.
20	S_LOAD	Input	Pulldown	Controls transition of data from shift register into the dividers. LVCMOS / LVTTL interface levels.
21	V <sub>DDA</sub>	Power		Analog supply pin.
22	XTAL_SEL	Input	Pullup	Selects between crystal or test inputs as the PLL reference source. Selects XTAL inputs when HIGH. Selects TEST_CLK when LOW. LVCMOS / LVTTL interface levels
23	TEST_CLK	Input	Pulldown	Test clock input. LVCMOS / LVTTL interface levels.
24, 25	XTAL_OUT, XTAL_IN	Input		Crystal oscillator interface. XTAL_IN is the input. XTAL_OUT is the output.
26	nP_LOAD	Input	Pulldown	Parallel load input. Determines when data present at M8:M0 is loaded into M divider, and when data present at N1:N0 sets the N output divider value. LVCMOS / LVTTL interface levels.
27	VCO_SEL	Input	Pullup	Determines whether synthesizer is in PLL or bypass mode. LVCMOS / LVTTL interface levels.

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.



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**TABLE 2. PIN CHARACTERISTICS**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$C_{IN}$	Input Capacitance			4		pF
$C_{PD}$	Power Dissipation Capacitance (per output)	$V_{DD}, V_{DDA}, V_{DDO} = 3.465V$		13		pF
		$V_{DD}, V_{DDA} = 3.465V, V_{DDO} = 2.625V$		11		pF
$R_{PULLUP}$	Input Pullup Resistor			51		kΩ
$R_{PULLDOWN}$	Input Pulldown Resistor			51		kΩ
$R_{OUT}$	Output Impedance		5	7	12	Ω

**TABLE 3A. PARALLEL AND SERIAL MODE FUNCTION TABLE**

Inputs							Conditions
MR	nP_LOAD	M	N	S_LOAD	S_CLOCK	S_DATA	
H	X	X	X	X	X	X	Reset. Forces outputs LOW.
L	L	Data	Data	X	X	X	Data on M and N inputs passed directly to the M divider and N output divider. TEST output forced LOW.
L	↑	Data	Data	L	X	X	Data is latched into input registers and remains loaded until next LOW transition or until a serial event occurs.
L	H	X	X	L	↑	Data	Serial input mode. Shift register is loaded with data on S_DATA on each rising edge of S_CLOCK.
L	H	X	X	↑	L	Data	Contents of the shift register are passed to the M divider and N output divider.
L	H	X	X	↓	L	Data	M divider and N output divider values are latched.
L	H	X	X	L	X	X	Parallel or serial input do not affect shift registers.
L	H	X	X	H	↑	Data	S_DATA passed directly to M divider as it is clocked.

NOTE: L = LOW

H = HIGH

X = Don't care

↑ = Rising edge transition

↓ = Falling edge transition



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TABLE 3B. PROGRAMMABLE VCO FREQUENCY FUNCTION TABLE

VCO Frequency (MHz)	M Divide	256	128	64	32	16	8	4	2	1
		M8	M7	M6	M5	M4	M3	M2	M1	M0
250	10	0	0	0	0	0	1	0	1	0
275	11	0	0	0	0	0	1	0	1	1
•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•
650	26	0	0	0	0	1	1	0	1	0
675	27	0	0	0	0	1	1	0	1	1
700	28	0	0	0	0	1	1	1	0	0

NOTE 1: These M divide values and the resulting frequencies correspond to crystal or TEST\_CLK input frequency of 25MHz.

TABLE 3C. PROGRAMMABLE OUTPUT DIVIDER FUNCTION TABLE

Inputs		N Divider Value	Output Frequency (MHz)	
			Minimum	Maximum
0	0	2	125	350
0	1	4	62.5	175
1	0	8	31.25	87.5
1	1	16	15.625	43.75

TABLE 3D. OUTPUT ENABLE & CLOCK ENABLE FUNCTION TABLE

Control Inputs		Output	
		Q0	Q1
0	0	Hi-Z	Hi-Z
0	1	Hi-Z	Enabled
1	0	Enabled	Hi-Z
1	1	Enabled	Enabled



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#### ABSOLUTE MAXIMUM RATINGS

Supply Voltage, $V_{DD}$	4.6V
Inputs, $V_I$	-0.5V to $V_{DD} + 0.5$ V
Outputs, $V_O$	-0.5V to $V_{DD} + 0.5$ V
Package Thermal Impedance, $\theta_{JA}$	
32 Lead LQFP	47.9°C/W (0 lfpm)
32 Lead VFQFN	34.8°C/W (0 lfpm)
Storage Temperature, $T_{STG}$	-65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the DC Characteristics or AC Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

**TABLE 4A. POWER SUPPLY DC CHARACTERISTICS,  $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{DD}$	Core Supply Voltage		3.135	3.3	3.465	V
$V_{DDA}$	Analog Supply Voltage		3.135	3.3	3.465	V
$V_{DDO}$	Output Supply Voltage		3.135	3.3	3.465	V
$I_{DD}$	Power Supply Current				125	mA
$I_{DDA}$	Analog Supply Current				18	mA
$I_{DDO}$	Output Supply Current				10	mA

**TABLE 4B. LVCMOS / LVTTL DC CHARACTERISTICS,  $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{IH}$	Input High Voltage	VCO_SEL, XTAL_SEL, MR, S_LOAD, nP_LOAD, S_DATA, S_CLOCK, OE0, OE1, N0:N1, M0:M8		2		$V_{DD} + 0.3$
		TEST_CLK		2		$V_{DD} + 0.3$
$V_{IL}$	Input Low Voltage	VCO_SEL, XTAL_SEL, MR, S_LOAD, nP_LOAD, S_DATA, S_CLOCK, OE0, OE1, N0:N1, M0:M8		-0.3		0.8
		TEST_CLK		-0.3		1.3
$I_{IH}$	Input High Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{DD} = V_{IN} = 3.465V$		150	$\mu A$
		M5, OE0, OE1, XTAL_SEL, VCO_SEL	$V_{DD} = V_{IN} = 3.465V$		5	$\mu A$
$I_{IL}$	Input Low Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{DD} = 3.465V$ , $V_{IN} = 0V$	-5		$\mu A$
		M5, OE0, OE1, XTAL_SEL, VCO_SEL	$V_{DD} = 3.465V$ , $V_{IN} = 0V$	-150		$\mu A$
$V_{OH}$	Output High Voltage; NOTE 1		2.6			V
$V_{OL}$	Output Low Voltage; NOTE 1				0.5	V

NOTE 1: Outputs terminated with  $50\Omega$  to  $V_{DD}/2$ .



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**TABLE 4C. POWER SUPPLY DC CHARACTERISTICS,  $V_{DD} = V_{DDA} = 3.3V \pm 5\%$ ,  $V_{DDO} = 2.5V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{DD}$	Core Supply Voltage		3.135	3.3	3.465	V
$V_{DDA}$	Analog Supply Voltage		3.135	3.3	3.465	V
$V_{DDO}$	Output Supply Voltage		2.375	2.5	2.625	V
$I_{DD}$	Power Supply Current				125	mA
$I_{DDA}$	Analog Supply Current				18	mA
$I_{DDO}$	Output Supply Current				10	mA

**TABLE 4D. LVCMOS / LVTTL DC CHARACTERISTICS,  $V_{DD} = V_{DDA} = 3.3V \pm 5\%$ ,  $V_{DDO} = 2.5V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{IH}$	Input High Voltage	VCO_SEL, XTAL_SEL, MR, S_LOAD, nP_LOAD, S_DATA, S_CLOCK, OE0, OE1, N0:N1, M0:M8		2	$V_{DD} + 0.3$	V
		TEST_CLK		2	$V_{DD} + 0.3$	V
$V_{IL}$	Input Low Voltage	VCO_SEL, XTAL_SEL, MR, S_LOAD, nP_LOAD, S_DATA, S_CLOCK, OE0, OE1, N0:N1, M0:M8		-0.3	0.8	V
		TEST_CLK		-0.3	1.3	V
$I_{IH}$	Input High Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{DD} = V_{IN} = 3.465V$		150	$\mu A$
		M5, OE0, OE1, XTAL_SEL, VCO_SEL	$V_{DD} = V_{IN} = 3.465V$		5	$\mu A$
$I_{IL}$	Input Low Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{DD} = 3.465V$ , $V_{IN} = 0V$	-5		$\mu A$
		M5, OE0, OE1, XTAL_SEL, VCO_SEL	$V_{DD} = 3.465V$ , $V_{IN} = 0V$	-150		$\mu A$
$V_{OH}$	Output High Voltage; NOTE 1			1.8		V
$V_{OL}$	Output Low Voltage; NOTE 1				0.5	V

NOTE 1: Outputs terminated with  $50\Omega$  to  $V_{DDO}/2$ .

**TABLE 5. INPUT FREQUENCY CHARACTERISTICS,  $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$f_{IN}$	Input Frequency	TEST_CLK; NOTE 1		12	40	MHz
		XTAL_IN, XTAL_OUT; NOTE 1		12	40	MHz
		S_CLOCK			50	MHz

NOTE 1: For the input crystal and TEST\_CLK frequency range, the M value must be set for the VCO to operate within the 250MHz to 700MHz range. Using the minimum input frequency of 12MHz, valid values of M are  $21 \leq M \leq 58$ . Using the maximum frequency of 40MHz, valid values of M are  $7 \leq M \leq 17$ .



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**TABLE 6. CRYSTAL CHARACTERISTICS**

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation	Fundamental				
Frequency		12		40	MHz
Equivalent Series Resistance (ESR)				50	$\Omega$
Shunt Capacitance ( $C_o$ )				7	pF
Drive Level				1	mW

**TABLE 7A. AC CHARACTERISTICS,  $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$F_{OUT}$	Output Frequency		15.625		350	MHz
$t_{JIT(cc)}$	Cycle-to-Cycle Jitter; NOTE 1, 3			40	80	ps
$t_{JIT(per)}$	Period Jitter, RMS; NOTE 1			8	20	ps
$t_{SK(o)}$	Output Skew; NOTE 2, 3				60	ps
$t_R / t_F$	Output Rise/Fall Time	20% to 80%	0.3		1.1	ns
$t_S$	Setup Time	M, N to nP_LOAD	5			ns
		S_DATA to S_CLOCK	5			ns
		S_CLOCK to S_LOAD	5			ns
$t_H$	Hold Time	M, N to nP_LOAD	5			ns
		S_DATA to S_CLOCK	5			ns
		S_CLOCK to S_LOAD	5			ns
$odc$	Output Duty Cycle		40		60	%
$t_{LOCK}$	PLL Lock Time				1	ms

See Parameter Measurement Information section.

NOTE 1: Jitter performance using XTAL inputs.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at  $V_{DD}/2$ .  
NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.



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**TABLE 7B. AC CHARACTERISTICS,  $V_{DD} = V_{DDA} = 3.3V \pm 5\%$ ,  $V_{DDO} = 2.5V \pm 5\%$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$F_{OUT}$	Output Frequency		15.625		350	MHz
$t_{JIT(cc)}$	Cycle-to-Cycle Jitter; NOTE 1, 3			40	80	ps
$t_{JIT(per)}$	Period Jitter, RMS; NOTE 1			8	15	ps
$t_{SK(o)}$	Output Skew; NOTE 2, 3				60	ps
$t_R / t_F$	Output Rise/Fall Time	20% to 80%	0.3		1.0	ns
$t_S$	Setup Time	M, N to nP_LOAD		5		ns
		S_DATA to S_CLOCK		5		ns
		S_CLOCK to S_LOAD		5		ns
$t_H$	Hold Time	M, N to nP_LOAD		5		ns
		S_DATA to S_CLOCK		5		ns
		S_CLOCK to S_LOAD		5		ns
odc	Output Duty Cycle		40		60	%
$t_{LOCK}$	PLL Lock Time				1	ms

See Parameter Measurement Information section.

NOTE 1: Jitter performance using XTAL inputs.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at  $V_{DDO}/2$ .

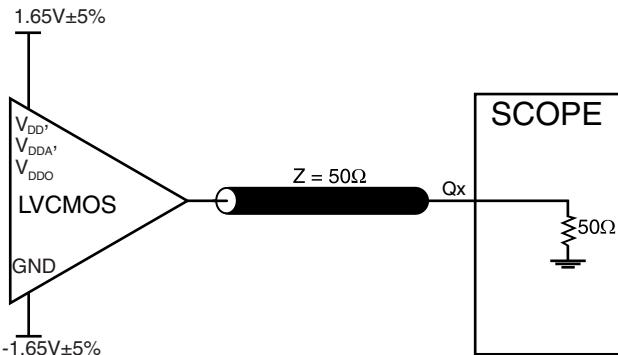
NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.



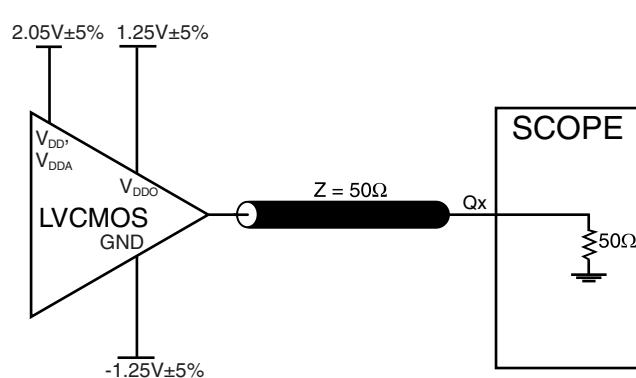
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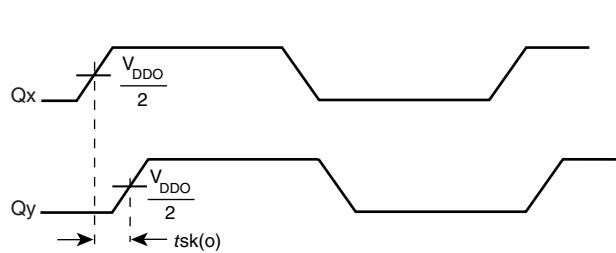
## PARAMETER MEASUREMENT INFORMATION



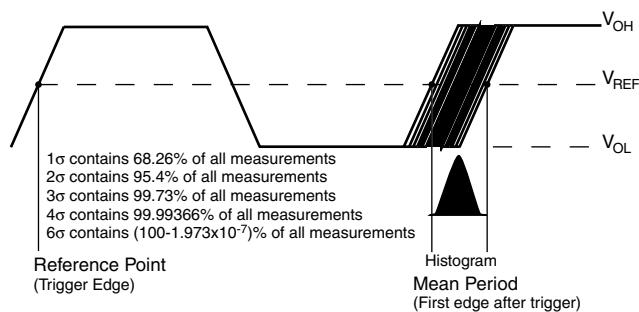
3.3V CORE/3.3V OUTPUT LOAD AC TEST CIRCUIT



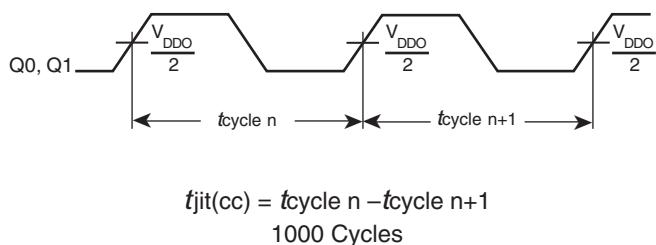
3.3V CORE/2.5V OUTPUT LOAD AC TEST CIRCUIT



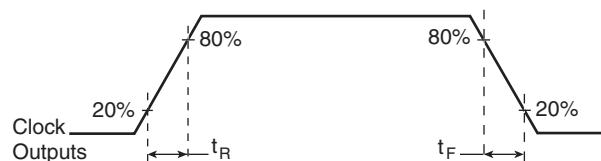
OUTPUT SKEW



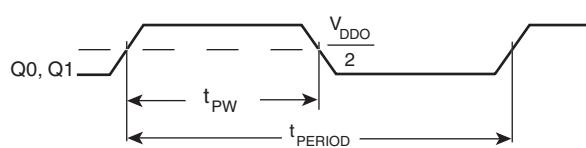
PERIOD JITTER



CYCLE-TO-CYCLE JITTER



OUTPUT RISE/FALL TIME



$$odc = \frac{t_{PW}}{t_{PERIOD}} \times 100\%$$

Output Duty Cycle/ $t_{PERIOD}$



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## APPLICATION INFORMATION

### POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS8402 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL.  $V_{DD}$ ,  $V_{DDA}$ , and  $V_{DDO}$  should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. Figure 2 illustrates how a  $10\Omega$  resistor along with a  $10\mu F$  and a  $.01\mu F$  bypass capacitor should be connected to each  $V_{DDA}$  pin. The  $10\Omega$  resistor can also be replaced by a ferrite bead.

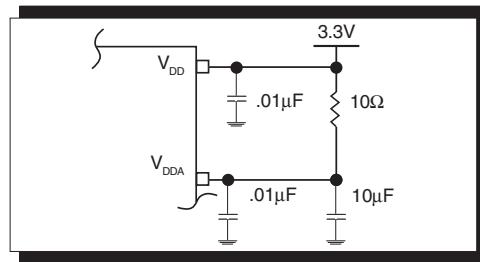


FIGURE 2. POWER SUPPLY FILTERING

### CRYSTAL INPUT INTERFACE

The ICS8402 has been characterized with 18pF parallel resonant crystals. The capacitor values, C1 and C2, shown in Figure 3 below were determined using a 25MHz, 18pF

parallel resonant crystal and were chosen to minimize the ppm error. The optimum C1 and C2 values can be slightly adjusted for different board layouts.

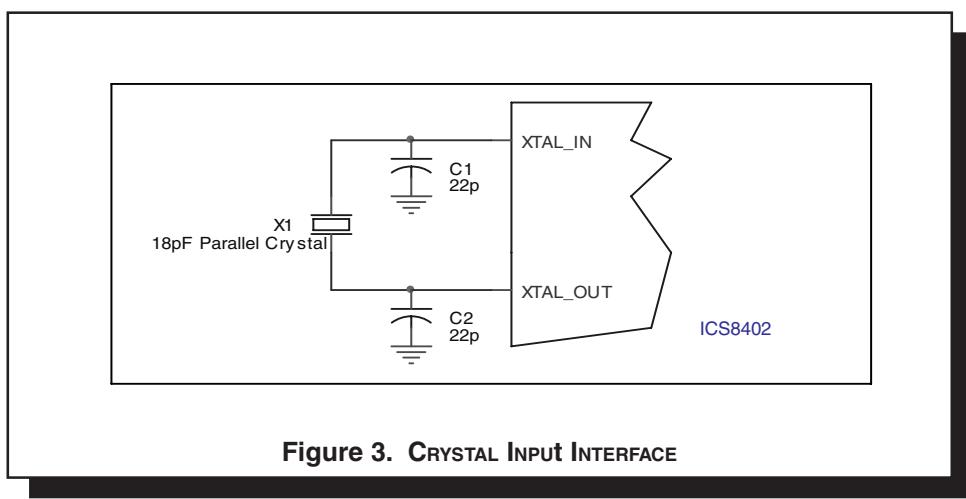


Figure 3. CRYSTAL INPUT INTERFACE



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## RELIABILITY INFORMATION

**TABLE 8A.  $\theta_{JA}$  vs. AIR FLOW TABLE FOR 32 LEAD LQFP**

<b><math>\theta_{JA}</math> by Velocity (Linear Feet per Minute)</b>			
	<b>0</b>	<b>200</b>	<b>500</b>
Single-Layer PCB, JEDEC Standard Test Boards	67.8°C/W	55.9°C/W	50.1°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	47.9°C/W	42.1°C/W	39.4°C/W
<b>NOTE:</b> Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.			

**TABLE 8B.  $\theta_{JA}$  vs. AIR FLOW TABLE FOR A 32 LEAD VFQFN**

<b><math>\theta_{JA}</math> 0 Air Flow (Linear Feet per Minute)</b>	
Multi-Layer PCB, JEDEC Standard Test Boards	34.8C/W

### TRANSISTOR COUNT

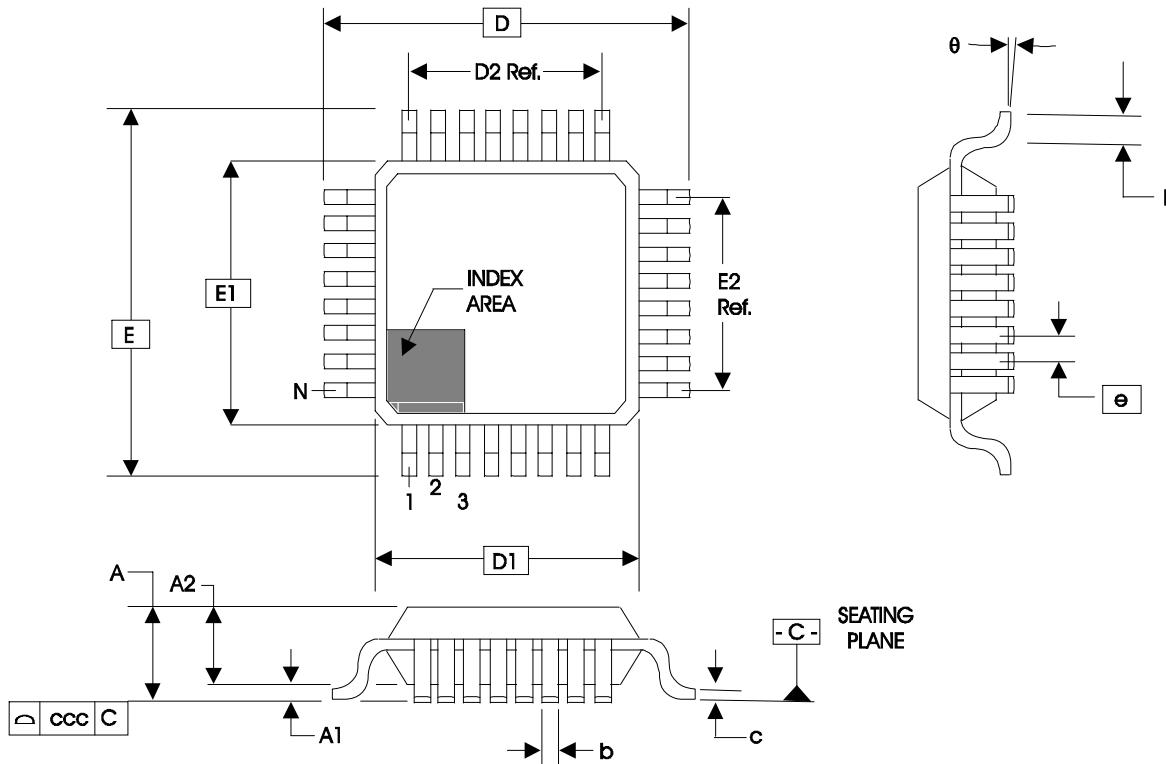
The transistor count for ICS8402 is: 3784



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**PACKAGE OUTLINE - Y SUFFIX FOR 32 LEAD LQFP**



**TABLE 9A. PACKAGE DIMENSIONS**

SYMBOL	JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS		
	BBA		
	MINIMUM	NOMINAL	MAXIMUM
N	32		
A	--	--	1.60
A1	0.05	--	0.15
A2	1.35	1.40	1.45
b	0.30	0.37	0.45
c	0.09	--	0.20
D	9.00 BASIC		
D1	7.00 BASIC		
D2	5.60 Ref.		
E	9.00 BASIC		
E1	7.00 BASIC		
E2	5.60 Ref.		
e	0.80 BASIC		
L	0.45	0.60	0.75
θ	0°	--	7°
ccc	--	--	0.10

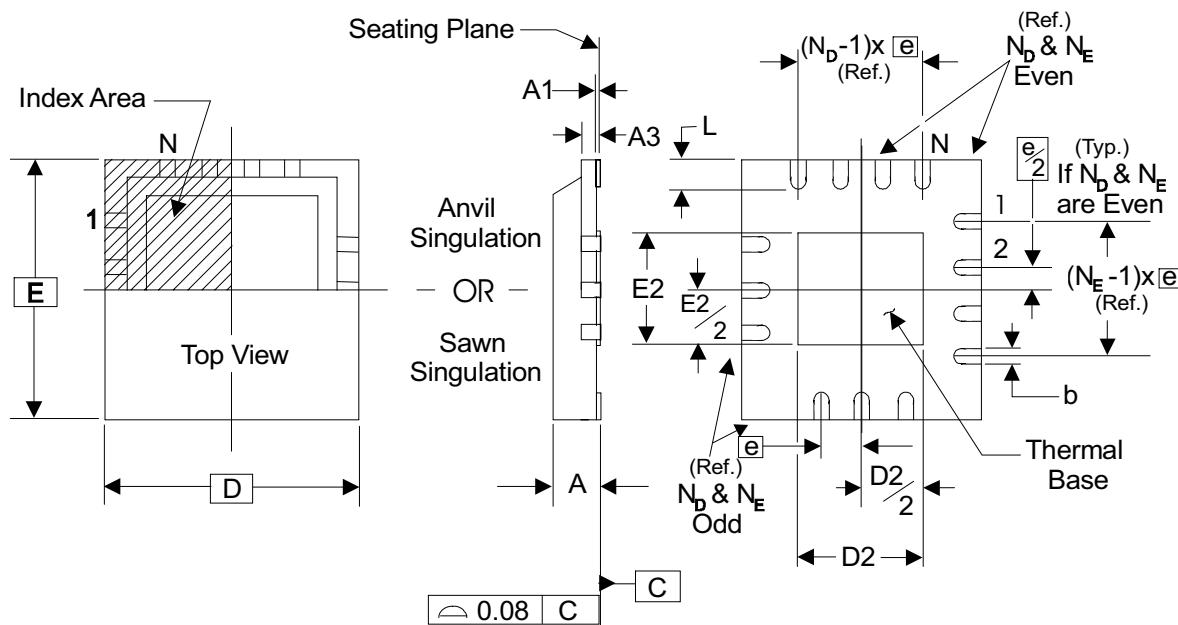
Reference Document: JEDEC Publication 95, MS-026



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**PACKAGE OUTLINE - K SUFFIX FOR A 32 LEAD VFQFN**



**TABLE 9B. PACKAGE DIMENSIONS**

SYMBOL	JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS		
	MINIMUM	NOMINAL	MAXIMUM
N	32		
A	0.80	--	1.00
A1	0	--	0.05
A3	0.25 Ref.		
b	0.18	0.25	0.30
$N_D$			8
$N_E$			8
D	5.00 BASIC		
D2	1.25	2.25	3.25
E	5.00 BASIC		
E2	1.25	2.25	3.25
e	0.50 BASIC		
L	0.30	0.40	0.50

Reference Document: JEDEC Publication 95, MO-220



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TABLE 10. ORDERING INFORMATION

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
ICS8402AYLF	ICS8402AYLF	32 Lead "Lead-Free" LQFP	tray	0°C to 70°C
ICS8402AYLFT	ICS8402AYLF	32 Lead "Lead-Free" LQFP	1000 tape & reel	0°C to 70°C
ICS8402AKLF	ICS8402AKLF	32 Lead "Lead-Free" VFQFN	tray	0°C to 70°C
ICS8402AKLFT	ICS8402AKLF	32 Lead "Lead-Free" VFQFN	2500 tape & reel	0°C to 70°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

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**REVISION HISTORY SHEET**

<b>Rev</b>	<b>Table</b>	<b>Page</b>	<b>Description of Change</b>	<b>Date</b>
B	7A	8	3.3V AC Characteristics Table, changed Output Rise/Fall Time 1.4ns max. to 1.1ns max.	8/1/03
	7B	8	3.3V/2.5V AC Characteristics Table, changed Output Rise/Fall Time 1.4ns max. to 1.0ns max.	
B	T1	3	Pin Description Table - corrected OE0 and OE1 pin name to correspond with the pin number.	11/4/03
B	T1	3	Pin Description Table - corrected placement of Q0, Q1 pins to correspond with Pin Assignment.	8/10/04
B	T8B T9B T10	1	Pin Assignment - added 32 Lead VFQFN package.	10/6/04
		6	AMR - added 32 Lead VFQFN Package Thermal Impedance.	
		11	Added 32 Lead VFQFN Thermal Resistance.	
		13	Add 32 Lead VFQFN Package Outline & Dimensions.	
		14	Ordering Information Table - added 32 Lead VFQFN ordering information	
C	T6 T10	1	Updated XTAL naming convention throughout the datasheet. Features section -Added Lead-Free bullet.	5/24/05
		2	Updated Parallel & Serial Load Operations diagram.	
		8	Crystal Characteristics Table - added Drive Level row.	
C	T10	15	Ordering Informatin Table - added LQFP Lead-Free part number.	9/1/05
		15	Ordering Information Table - added VFQFN Lead-Free part number.	

11/26/14

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Table 10 Ordering Information - removed leaded devices